Motion SPM® 3 Series

Description

FNB33060T6 is an advanced Motion SPM 3 module providing a fully-featured, high-performance inverter output stage for AC Induction, BLDC, and PMSM motors. These modules integrate optimized gate drive of the built-in IGBTs to minimize EMI and losses, while also providing multiple on-module protection features including under-voltage lockouts, over-current shutdown, thermal monitoring of drive IC, and fault reporting. The built-in, high-speed HVIC requires only a single supply voltage and translates the incoming logic-level gate inputs to the high-voltage, high-current drive signals required to properly drive the module's internal IGBTs. Separate negative IGBT terminals are available for each phase to support the widest variety of control algorithms.

Features

- 600 V 30 A 3-Phase IGBT Inverter with Integral Gate Drivers and Protection
- Low-Loss, Short-Circuit Rated IGBTs
- Very Low Thermal Resistance using Al₂O₃ DBC Substrate
- Built-In Bootstrap Diodes and Dedicated Vs Pins Simplify PCB
- Separate Open-Emitter Pins from Low-Side IGBTs for Three-Phase **Current Sensing**
- Single-Grounded Power Supply
- LVIC Temperature-Sensing Built-In for Temperature Monitoring
- Isolation Rating: 2500 V_{rms} / 1 min.
- This Device is Pb-Free and is RoHS Compliant

Applications

• Motion Control - Home Appliance / Industrial Motor

Related Resources

- AN-9088 Motion SPM 3 V6 Series Users Guide
- AN-9086 SPM 3 Package Mounting Guide



ON Semiconductor®

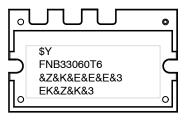
www.onsemi.com



3D Package Drawing (Click to Activate 3D Content)

> SPM27-CF, **CASE MODFL**

MARKING DIAGRAM



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Data Code (Year & Week) = Lot &K

FNB33060T6 = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet

PACKAGE MARKING AND ORDERING INFORMATION

Device	Device Marking	Package	Packing	Quantity
FNB33060T6	FNB33060T6	SPM27-CF	Rail	10

Integrated Power Functions

• 600 V – 30 A IGBT inverter for three–phase DC / AC power conversion (Please refer to Figure 3)

Integrated Drive, Protection and System Control Functions

- For Inverter High-side IGBTs: Gate drive circuit, high-voltage isolated high-speed level shiftingcontrol circuit Under-Voltage Lock-Out Protection (UVLO)
- NOTE: Available bootstrap circuit example is given in Figures 4 and 14
- For Inverter Low-side IGBTs:
 Gate drive circuit, Short-Circuit Protection (SCP)
 control supply circuit Under-Voltage Lock-Out
 Protection (UVLO)
- Fault Signaling: corresponding to UVLO (low-side supply) and SC faults
- Input Interface: Active-HIGH interface, works with 3.3 / 5 V logic, Schmitt-trigger input

Pin Configuration

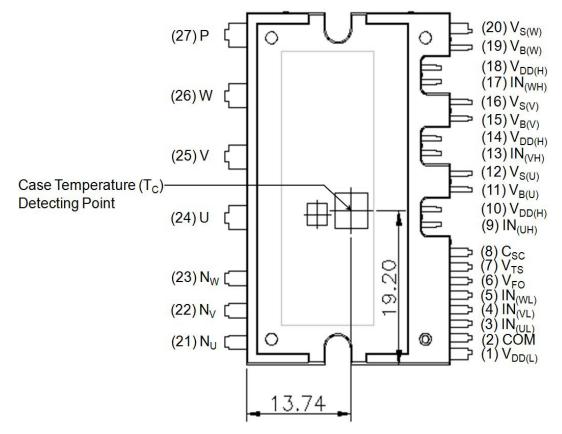


Figure 1. Top View

PIN DESCRIPTIONS

Pin No.	Pin Name	Pin Description
1	V _{DD(L)}	Low-Side Common Bias Voltage for IC and IGBTs Driving
2	СОМ	Common Supply Ground
3	IN _(UL)	Signal Input for Low-Side U-Phase
4	IN _(VL)	Signal Input for Low-Side V-Phase
5	IN _(WL)	Signal Input for Low-Side W-Phase
6	V _{FO}	Fault Output
7	V _{TS}	Output for LVIC Temperature Sensing Voltage Output
8	C _{SC}	Shut Down Input for Short-Circuit Current Detection Input
9	IN _(UH)	Signal Input for High-Side U-Phase
10	V _{DD(H)}	High-Side Common Bias Voltage for IC and IGBTs Driving
11	V _{B(U)}	High-Side Bias Voltage for U-Phase IGBT Driving
12	V _{S(U)}	High-Side Bias Voltage Ground for U-Phase IGBT Driving
13	IN _(VH)	Signal Input for High-Side V-Phase
14	V _{DD(H)}	High-Side Common Bias Voltage for IC and IGBTs Driving
15	V _{B(V)}	High-Side Bias Voltage for V-Phase IGBT Driving
16	V _{S(V)}	High-Side Bias Voltage Ground for V Phase IGBT Driving
17	IN _(WH)	Signal Input for High-Side W-Phase
18	V _{DD(H)}	High-Side Common Bias Voltage for IC and IGBTs Driving
19	V _{B(W)}	High-Side Bias Voltage for W-Phase IGBT Driving
20	V _{S(W)}	High-Side Bias Voltage Ground for W-Phase IGBT Driving
21	N _U	Negative DC-Link Input for U-Phase
22	N _V	Negative DC-Link Input for V-Phase
23	N _W	Negative DC-Link Input for W-Phase
24	U	Output for U-Phase
25	V	Output for V-Phase
26	W	Output for W-Phase
27	Р	Positive DC-Link Input

Internal Equivalent Circuit and Input/Output Pins

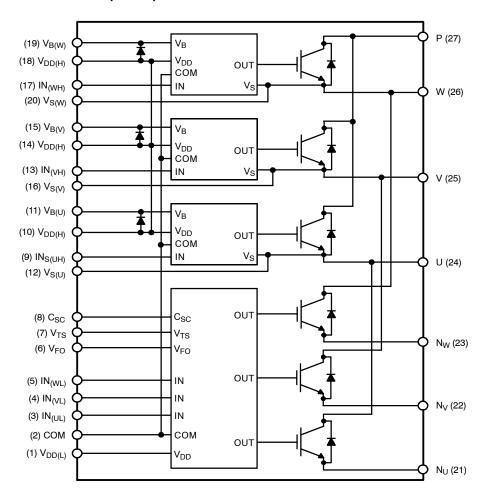


Figure 2. Internal Block Diagram

- 1. Inverter low-side is composed of three IGBTs, freewheeling diodes for each IGBT, and one control IC. It has gate drive and protection functions.
- 2. Inverter power side is composed of four inverter DC-link input terminals and three inverter output terminals.
- 3. Inverter high-side is composed of three IGBTs, freewheeling diodes, and three drive ICs for each IGBT.

ABSOLUTE MAXIMUM RATINGS (T_{.J} = 25°C, Unless Otherwise Specified)

Symbol	Parameter	Conditions	Rating	Unit
INVERTER	PART			
V _{PN}	Supply Voltage	Applied between P – N _U , N _V , N _W	450	V
VP _{N(Surge)}	Supply Voltage (Surge)	Applied between P – N _U , N _V , N _W	500	V
V_{CES}	Collector - Emitter Voltage		600	٧
± I _C	Each IGBT Collector Current	$T_C = 25^{\circ}C, T_J \le 150^{\circ}C \text{ (Note 4)}$	30	Α
± I _{CP}	Each IGBT Collector Current (Peak)	Furrent (Peak) $T_C = 25^{\circ}C$, $T_J \le 150^{\circ}C$, Under 1 ms Pulse Width (Note 4)		Α
P _C	Collector Dissipation	T _C = 25°C per One Chip (Note 4)	89	W
T_J	Operating Junction Temperature		-40~150	ô
CONTROL	PART			
V_{DD}	Control Supply Voltage	Applied between V _{DD(H)} , V _{DD(L)} – COM	20	٧
V_{BS}	High-Side Control Bias Voltage	Applied between $V_{B(U)}$ – $V_{S(U)}$, $V_{B(V)}$ – $V_{S(V)}$, $V_{B(W)}$ – $V_{S(W)}$	20	V
V _{IN}	Input Signal Voltage	Applied between $IN_{(UH)}$, $IN_{(VH)}$, $IN_{(WH)}$, $IN_{(UL)}$, $IN_{(VL)}$, $IN_{(VL)}$	-0.3~V _{DD} +0.3	V
V _{FO}	Fault Output Supply Voltage	Applied between V _{FO} – COM	-0.3~V _{DD} +0.3	٧
I _{FO}	Fault Output Current	Sink Current at V _{FO} pin	2	mA
V _{SC}	Current Sensing Input Voltage	Applied between C _{SC} – COM	-0.3~V _{DD} +0.3	٧
BOOTSTRA	AP DIODE PART			
V_{RRM}	Maximum Repetitive Reverse Voltage		600	V
I _F	Forward Current	T _C = 25°C, T _J ≤ 150°C (Note 4)	0.5	Α
I _{FP}	Forward Current (Peak)	T_C = 25°C, T_J ≤ 150°C, Under 1 ms Pulse Width (Note 4)	2.0	Α
T_J	Operating Junction Temperature		-40~150	°C
TOTAL SYS	STEM			
V _{PN(PROT)}	Self Protection Supply Voltage Limit (Short Circuit Protection Capability)	V_{DD} = V_{BS} = 13.5~16.5 V, T_{J} = 150°C, Non–repetitive, < 2 μs	400	V
T _C	Module Case Operation Temperature	See Figure 1	-40~125	°C
T _{STG}	Storage Temperature		-40~125	°C
V _{ISO}	Isolation Voltage	60 Hz, Sinusoidal, AC 1 minute, Connection Pins to Heat Sink Plate	2500	V _{rms}

THERMAL RESISTANCE

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
R _{th(j-c)Q}	Junction to Case Thermal Resistance	Inverter IGBT part (per 1 / 6 module)	-	Ì	1.4	°C/W
R _{th(j-c)} F	(Note 5)	Inverter FWD part (per 1 / 6 module)	-	-	2.4	°C/W

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

^{4.} These values had been made an acquisition by the calculation considered to design factor.

^{5.} For the measurement point of case temperature (T_C), please refer to Figure 1.

ELECTRICAL CHARACTERISTICS (T_J = 25°C, Unless Otherwise Specified)

S	ymbol	Parameter	Test Cond	litions	Min.	Тур.	Max.	Unit		
INVE	RTER PAF	rT	•		•	•	•	•		
Vo	CE(SAT)	Collector - Emitter Saturation Voltage	V _{DD} = V _{BS} = 15 V V _{IN} = 5 V	I _C = 30 A, T _J = 25°C	_	1.6	2.2	V		
	V _F	FWDi Forward Voltage	V _{IN} = 0 V		-	2.0	2.6	٧		
HS	t _{ON}	Switching Times	$V_{PN} = 300 \text{ V}, V_{DD} = 15 \text{ V}, I_{C} = 30 \text{ A}, T_{J} = 25^{\circ}\text{C}$			0.90	1.40	μs		
	t _{C(ON)}		V _{IN} = 0 V ↔ 5 V, Inductive Load See Figure 4 (Note 6)		See Figure 4		_	0.20	0.60	μs
	t _{OFF}				_	0.85	1.35	μs		
	t _{C(OFF)}				_	0.15	0.45	μs		
	t _{rr}				-	0.08	-	μs		
LS	t _{ON}		$V_{PN} = 300 \text{ V}, V_{DD} = 15 \text{ V}, I_{C}$		0.40	0.80	1.30	μs		
	t _{C(ON)}		$V_{IN} = 0 \text{ V} \leftrightarrow 5 \text{ V}$, Inductive I See Figure 4	Load	-	0.25	0.60	μs		
	t _{OFF}		(Note 6)		_	0.90	1.40	μs		
	t _{C(OFF)}				_	0.15	0.45	μs		
	t _{rr}				_	0.10	_	μs		
	I _{CES}	Collector - Emitter Leakage Current	V _{CE} = V _{CES}		-	-	5	mA		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product

performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. t_{ON} and t_{OFF} include the propagation delay time of the internal drive IC. t_{C(ON)} and t_{C(OFF)} are the switching time of IGBT itself under the given gate driving condition internally. For the detailed information, *please see Figure 3*.

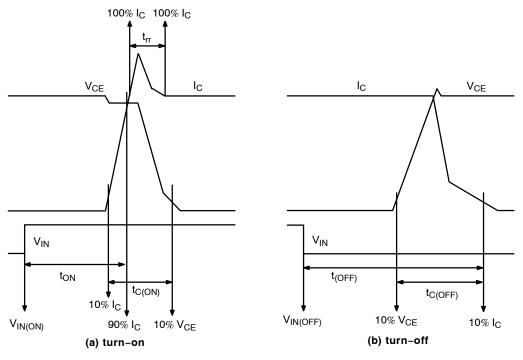


Figure 3. Switching Time Definition

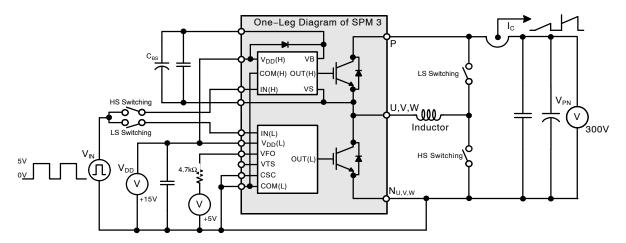


Figure 4. Example Circuit for Switching Test

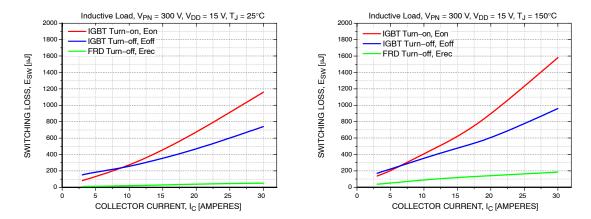


Figure 5. Switching Loss Characterstics

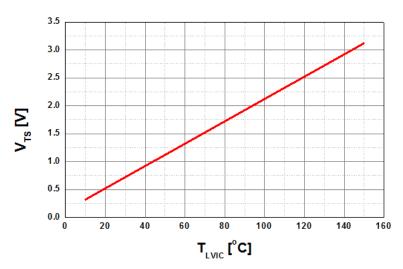


Figure 6. Temperature Profile of V_{TS} (Typical)

BOOTSTRAP DIODE PART

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
V _F	Forward Voltage	I _F = 0.1 A, T _J = 25°C	-	2.5	1	V
t _{rr}	Reverse Recovery Time	$I_F = 0.1 \text{ A, } dI_F / dt = 50 \text{ A} / \mu \text{s, } T_J = 25^{\circ}\text{C}$	-	80	-	ns

CONTROL PART

Symbol	Parameter	Min	Conditions	Min.	Тур.	Max.	Unit
I _{QDDH}	Quiescent V _{DD} Supply Current	V _{DD(H)} = 15 V, IN _(UH,VH,WH) = 0 V	VDD(H) - COM	-	-	0.50	mA
I _{QDDL}		V _{DD(L)} = 15 V, IN _(UL,VL, WL) = 0 V	VDD(L) – COM	-	-	6.00	mA
I _{PDDH}	Operating V _{DD} Supply Current	V _{DD(H)} = 15 V, f _{PWM} = 20 kHz, duty = 50%, applied to one PWM signal input for High–Side		-	-	0.50	mA
I _{PDDL}		V _{DD(L)} = 15 V, f _{PWM} = 20 kHz, duty = 50%, applied to one PWM signal input for Low–Side	V _{DD(L)} – COM	-	-	10.0	mA
I _{QBS}	Quiescent V _{BS} Supply Current	V _{BS} = 15 V, IN _(UH, VH, WH) = 0 V	VB(U) - VS(U), VB(V) - VS(V), VB(W) - VS(W)	-	-	0.30	mA
I _{PBS}	Operating V _{BS} Supply Current	V _{DD} = V _{BS} = 15 V, f _{PWM} = 20 kHz, duty = 50%, applied to one PWM signal input for High–Side	VB(U) - VS(U), VB(V) - VS(V), VB(W) - VS(W)	-	-	4.50	mA
V _{FOH}	Fault Output Voltage	V_{DD} = 15 V, V_{SC} = 0 V, V_{FO} Circuit: 4.7 k Ω to 5 V Pull-up	V _{FO} Circuit: 4.7 kΩ to 5 V		-	_	V
V _{FOL}		V_{DD} = 15 V, V_{SC} = 1 V, V_{FO} Circuit: 4.7 k Ω to 5 V Pull-up		-	-	0.5	V
V _{SC(ref)}	Short Circuit Trip Level	V _{DD} = 15 V (Note 7)	C _{SC} – COM _(L)	0.45	0.50	0.55	V
UV_{DDD}	Supply Circuit Under – Voltage Protection	Detection Level		9.8	-	13.3	V
UV_{DDR}	- Voltage Protection	Reset Level		10.3	-	13.8	V
UV _{BSD}		Detection Level		9.0	-	12.5	V
UV _{BSR}		Reset Level		9.5	-	13.0	V
t _{FOD}	Fault-Out Pulse Width			50	-	-	μS
V _{TS}	LVIC Temperature Sensing Voltage Output	V _{DD(L)} = 15 V, T _{LVIC} = 25°C (Note 8) See Figure 6		540	640	740	mV
V _{IN(ON)}	ON Threshold Voltage	Applied between IN _(UH, VH, WH)	- COM,	-	-	2.6	V
V _{IN(OFF)}	OFF Threshold Voltage	IN _(UL, VL, WL) – COM		0.8	_	_	V

^{7.} Short-circuit current protection is functioning only at the low-sides.
8. T_{LVIC} is the temperature of LVIC itself. V_{TS} is only for sensing temperature of LVIC and can not shutdown IGBTs automatically.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
V _{PN}	Supply Voltage	Applied between P - N _U , N _V , N _W	-	300	400	V
V _{DD}	Control Supply Voltage	Applied between V _{DD(H)} – COM, V _{DD(L)} – COM	14.0	15	16.5	V
V _{BS}	High-Side Bias Voltage	$ \begin{array}{c} \text{Applied between } V_{B(U)} - V_{S(U)}, \\ V_{B(V)} - V_{S(V)}, V_{B(W)} - V_{S(W)} \end{array} $	13.0	15	18.5	V
dV _{DD} / dt, dV _{BS} / dt	Control Supply Variation		- 1	-	1	V/μs
t _{dead}	Blanking Time for Preventing Arm – Short	For Each Input Signal	1.0	-	_	μs
f _{PWM}	PWM Input Signal	$-40^{\circ}\text{C} \le \text{T}_{\text{C}} \le 125^{\circ}\text{C}, -40^{\circ}\text{C} \le \text{T}_{\text{J}} \le 150^{\circ}\text{C}$	-	-	20	kHz
V _{SEN}	Voltage for Current Sensing	Applied between N _U , N _V , N _W – COM (Including Surge Voltage)	-5		5	V
PW _{IN(ON)}	Minimum Input Pulse Width	$V_{DD} = V_{BS} = 15 \text{ V}, I_C \le 60 \text{ A},$	2.0	_	-	μs
PW _{IN(OFF)}	1	Wiring Inductance between $N_{U,\ V,\ W}$ and DC Link N < 10 nH (Note 9)	2.0	_	-	μs
TJ	Junction Temperature		-40	_	150	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

9. This product might not make response if input pulse width is less than the recommanded value.

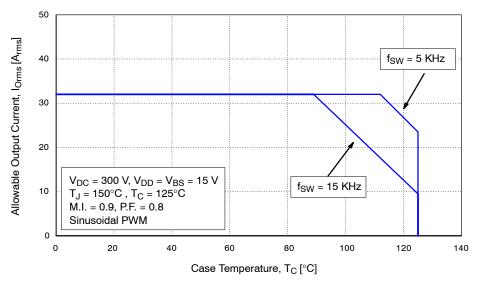


Figure 7. Allowable Maximum Output Current

10. This allowable output current value is the reference data for the safe operation of this product. This may be different from the actual application and operating condition.

MECHANICAL CHARACTERISTISC AND RATINGS

			Limits			
Parameter	c	Conditions	Min.	Тур.	Max.	Unit
Device Flatness	See Figure 8		0	-	+150	μm
Mounting Torque	Mounting Screw: M3	Recommended 0.7 N/m	0.6	0.7	0.8	N/m
	See Figure 9	Recommended 7.1 kg/cm	6.2	7.1	8.1	kg/cm
Terminal Pulling Strength	Load 19.6 N		10	-	-	s
Terminal Bending Strength	Load 9.8 N, 90 deg. bend		2	-	-	times
Weight			-	15	-	g

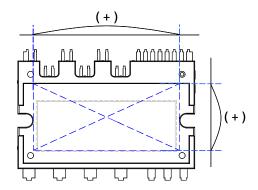


Figure 8. Flatness Measurement Position

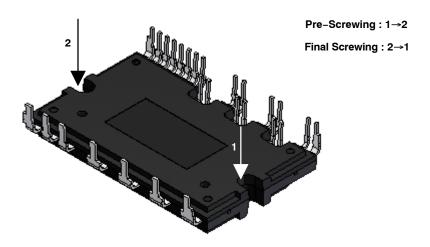


Figure 9. Mounting Screws Torque Order

- 11. Do not make over torque when mounting screws. Much mounting torque may cause DBC cracks, as well as bolts and Al heat-sink destruction.
- 12. Avoid one–sided tightening stress. Figure 9 shows the recommended torque order for mounting screws. Uneven mounting can cause the DBC substrate of package to be damaged. The pre–screwing torque is set to 20 ~ 30% of maximum torque rating.

Time Charts of SPMs Protective Function

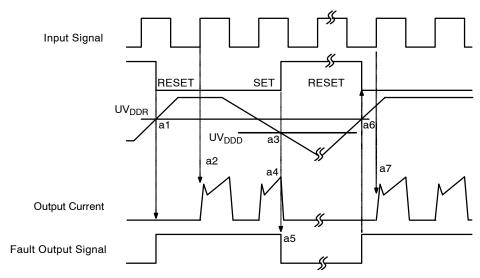


Figure 10. Under-Voltage Protection (Low-Side)

- a1: Control supply voltage rises: After the voltage rises UVDDR, the circuits start to operate when next input is applied.
- a2: Normal operation: IGBT ON and carrying current.
- a3 : Under voltage detection (UV_{DDD}).
- a4: IGBT OFF in spite of control input condition.
- a5 : Fault output operation starts with a fixed pulse width.
- a6 : Under voltage reset (UV_{DDR}).
- a7 : Normal operation: IGBT ON and carrying current by triggering next signal from LOW to HIGH.

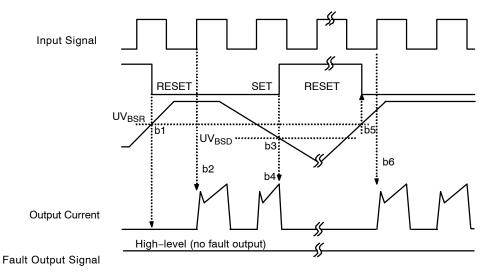


Figure 11. Under-Voltage Protection (High-Side)

- b1 : Control supply voltage rises: After the voltage reaches UVBSR, the circuits start to operate when next input is applied.
- b2: Normal operation: IGBT ON and carrying current.
- b3 : Under voltage detection (UV_{BSD}).
- b4: IGBT OFF in spite of control input condition, but there is no fault output signal.
- b5 : Under voltage reset (UV_{BSR}).
- b6: Normal operation: IGBT ON and carrying current by triggering next signal from LOW to HIGH.

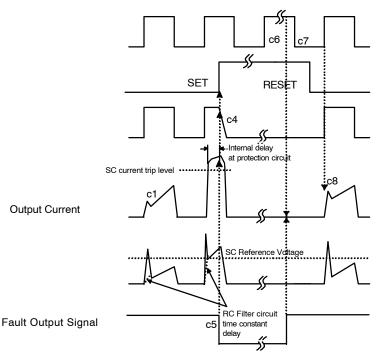


Figure 12. Under-Voltage Protection (Low-Side)

(with the external sense resistance and RC filter connection)

- c1 : Normal operation: IGBT ON and carrying current.
- c2: Short circuit current detection (SC trigger).
- c3 : All low-side IGBT's gate are hard interrupted.
- c4: All low-side IGBTs turn OFF.
- c5 : Fault output operation starts with a fixed pulse width.
- c6: Input HIGH: IGBT ON state, but during the active period of fault output the IGBT doesn't turn ON.
- c7: Fault output operation finishes, but IGBT doesn't turn on until triggering next signal from LOW to HIGH.
- c8: Normal operation: IGBT ON and carrying current.

Input/Output Interface Circuit

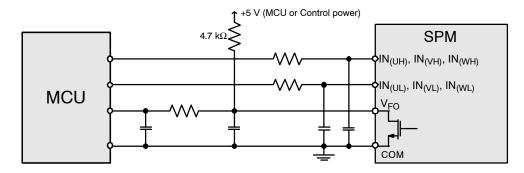


Figure 13. Recommended CPU I/O Interface Circuit

13.RC coupling at each input might change depending on the PWM control scheme used in the application and the wiring impedance of the application's printed circuit board. The input signal section of the Motion SPM 3 product integrates $5 \text{ k}\Omega$ (typ.) pull-down resistor. Therefore, when using an external filtering resistor, please pay attention to the signal voltage drop at input terminal.

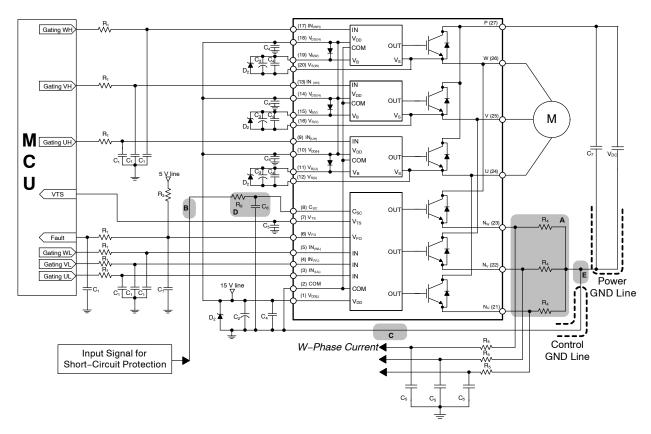
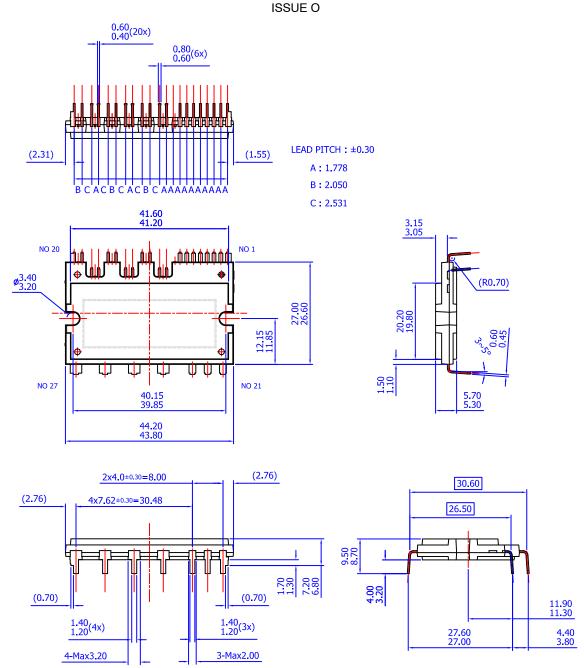


Figure 14. Recommended CPU I/O Interface Circuit

- 14. To avoid malfunction, the wiring of each input should be as short as possible. (less than 2-3 cm)
- 15. V_{FO} output is open–drain type. This signal line should be pulled up to the positive side of the MĆU or control power supply with a resistor that makes I_{FO} up to 2 mA. Please refer to Figure 13.
- 16. Input signal is active–HIGH type. There is a 5 k Ω resistor inside the IC to pull–down each input signal line to GND. RC coupling circuits should be adopted for the prevention of input signal oscillation. R₁C₁ time constant should be selected in the range 50 ~ 150 ns. (Recommended R₁ = 100 Ω , C₁ = 1 nF)
- 17. Each wiring pattern inductance of A point should be minimized (Recommend less than 10 nH). Use the shunt resistor R₄ of surface mounted (SMD) type to reduce wiring inductance. To prevent malfunction, wiring of point E should be connected to the terminal of the shunt resistor R₄ as close as possible.
- 18. To prevent errors of the protection function, the wiring of B, C, and D point should be as short as possible.
- 19. In the short–circuit protection circuit, please select the R₆C₆ time constant in the range 1.5 ~ 2 µs. Do enough evaluaiton on the real system because short–circuit protection time may vary wiring pattern layout and value of the R₆C₆ time constant.
- 20. Each capacitor should be mounted as close to the pins of the Motion SPM 3 product as possible.
- 21. To prevent surge destruction, the wiring between the smoothing capacitor C₇ and the P & GND pins should be as short as possible. The use of a high–frequency non–inductive capacitor of around 0.1 ~ 0.22 μF between the P & GND pins is recommended.
- 22. Relays are used at almost every systems of electrical equipments at industrial application. In these cases, there should be sufficient distance between the CPU and the relays.
- 23. The zener diode or transient voltage suppressor should be adopted for the protection of ICs from the surge destruction between each pair of control supply terminals (Recommanded zener diode is 22 V / 1 W, which has the lower zener impedance characteristic than about 15 Ω).
- 24. C₂ of around 7 times larger than bootstrap capacitor C₃ is recommended.
- 25. Please choose the electrolytic capacitor with good temperature characteristic in C_3 . Also, choose 0.1 ~ 0.2 μ F R-category ceramic capacitors with good temperature and frequency characteristics in C_4 .

PACKAGE DIMENSIONS

SPMCF-027 / PDD, STD, SPM27-CF, SHORT LEAD (Special) CUSTOMER SPECIFIC OPTION CASE MODFL



NOTES: UNLESS OTHERWISE SPECIFIED

- A) THIS PACKAGE DOES NOT COMPLY TO ANY CURRENT PACKAGING STANDARD
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- D) () IS REFERENCE

SPM is a registered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries.

ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hol

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303–675–2175 or 800–344–3860 Toll Free USA/Canada Fax: 303–675–2176 or 800–344–3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800–282–9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

♦ FNB33060T6/D